

November 5, 2021



Inter-University Research Institute Corporation /
Research Organization of Information and Systems

National Institute of Informatics

Supervised Pattern Mining

Data Mining 04 (データマイニング)

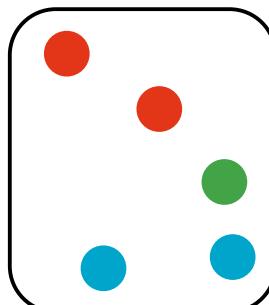
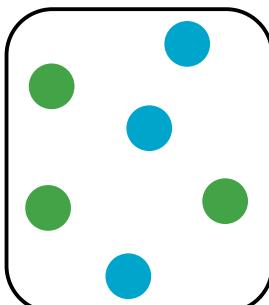
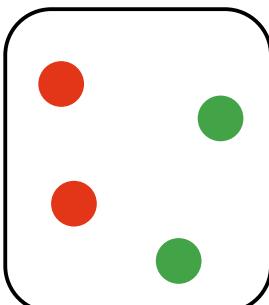
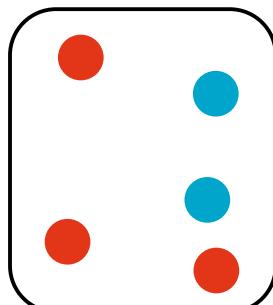
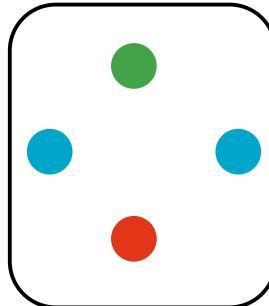
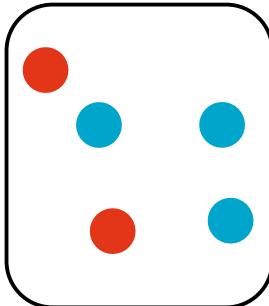
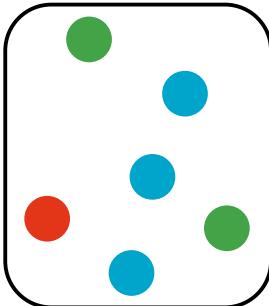
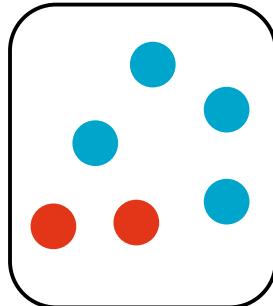
Mahito Sugiyama (杉山麿人)

Today's Outline

- Pattern mining with class labels (supervision)
 - Various measures
- Significant pattern mining
 - Statistical tests
 - Testable patterns
 - Controlling the FWER (Family-Wise Error Rate) by Tarone's testability trick

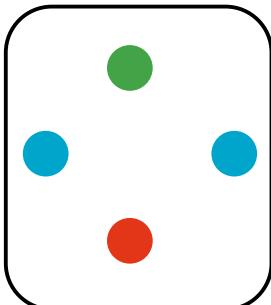
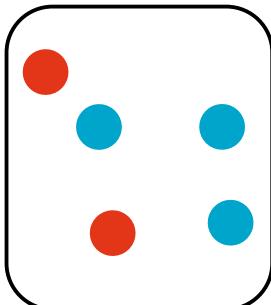
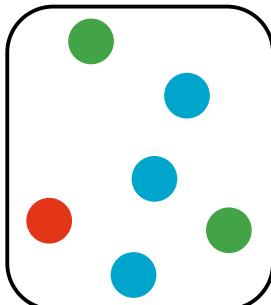
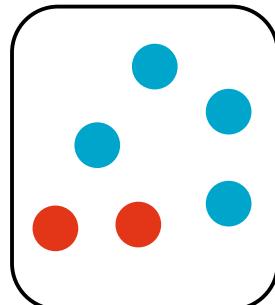
Itemset Mining

- Find interesting combinatorial patterns from massive data

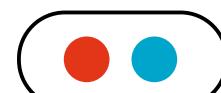


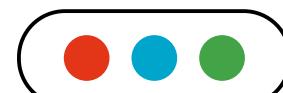
Itemset Mining

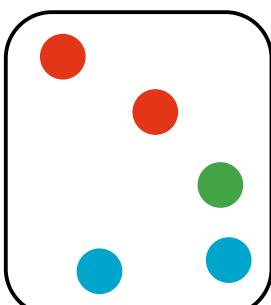
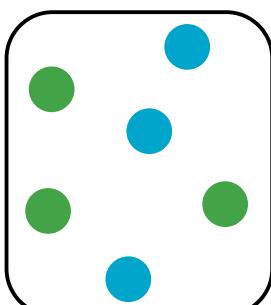
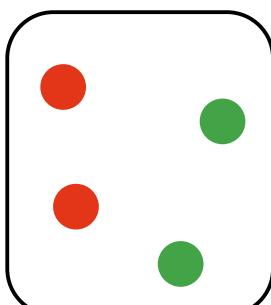
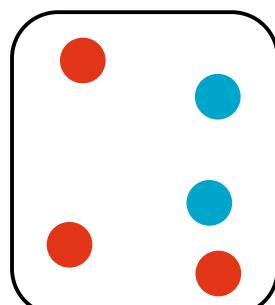
- Find interesting combinatorial patterns from massive data



Itemset
(combination
of colors)

 Support: 6

 Support: 3

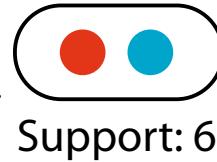


Itemset Mining (Binary Representation)

- Find interesting combinatorial patterns from massive data

	●	●	●
ID1	1	1	0
ID2	1	1	1
ID3	1	1	0
ID4	1	1	1
ID5	1	1	0
ID6	0	1	1
ID7	1	0	1
ID8	1	1	1

Itemset
(combination
of colors)



Support: 6



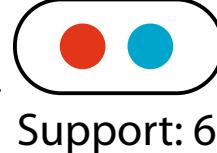
Support: 3

Itemset Mining (Binary Representation)

- Find interesting combinatorial patterns from massive data

	Blue	Red	Green
ID1	1	1	0
ID2	1	1	1
ID3	1	1	0
ID4	1	1	1
ID5	1	1	0
ID6	0	1	1
ID7	1	0	1
ID8	1	1	1

Itemset
(combination
of colors)



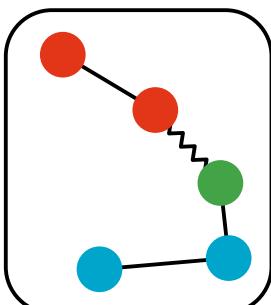
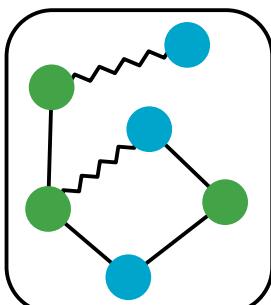
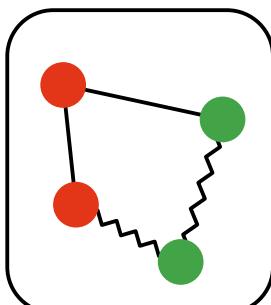
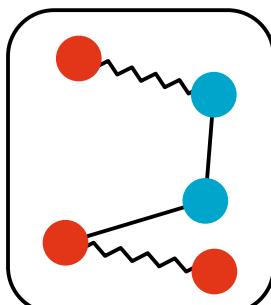
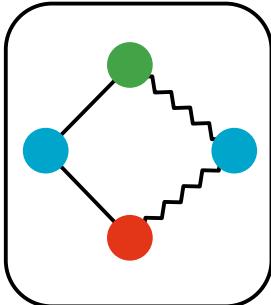
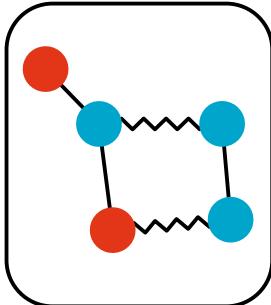
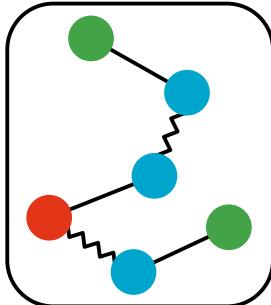
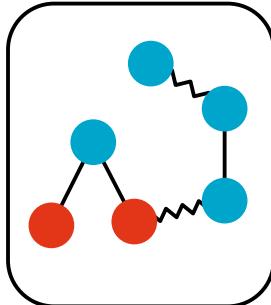
Support: 6



Support: 3

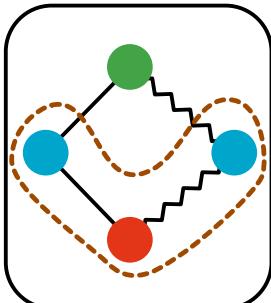
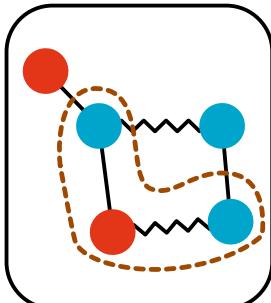
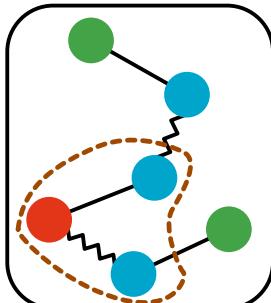
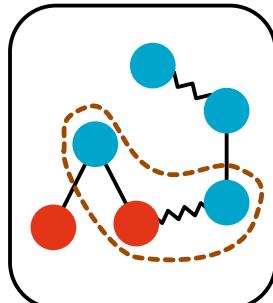
Subgraph Mining

- Find interesting combinatorial patterns from massive data

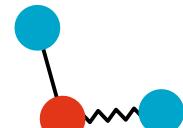


Subgraph Mining

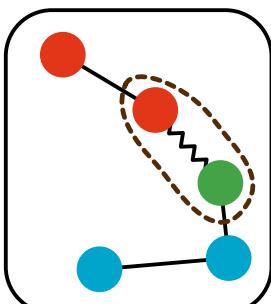
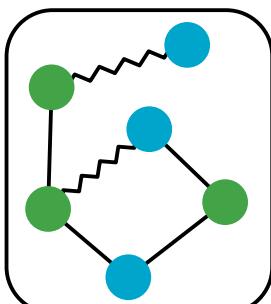
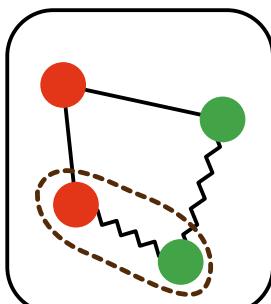
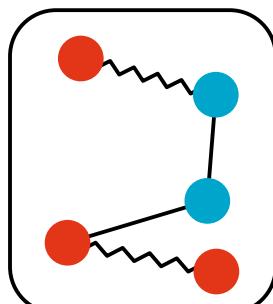
- Find interesting combinatorial patterns from massive data



Subgraph



Support: 4

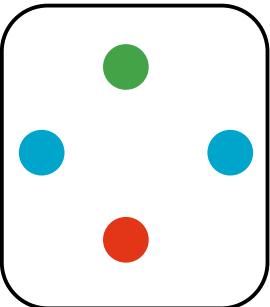
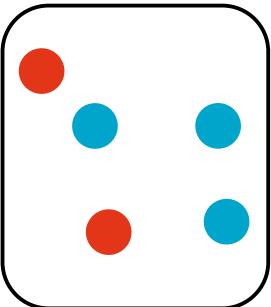
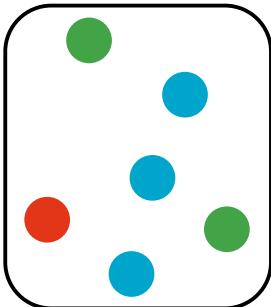
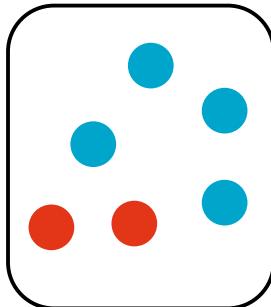


Support: 2

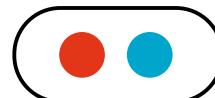
Supervised Itemset Mining

- Find discriminative patterns from supervised data

Positive

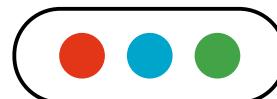
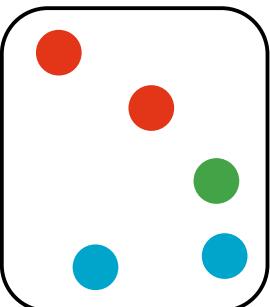
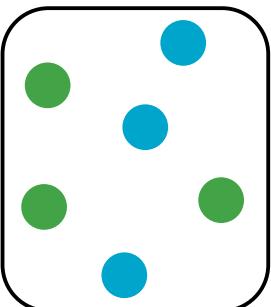
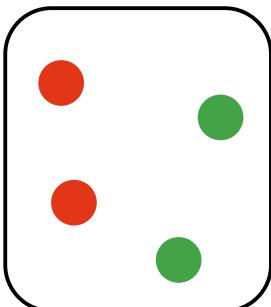
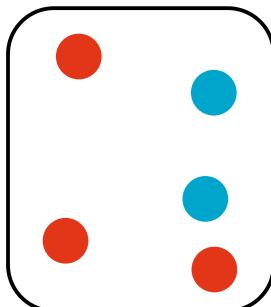


Discriminative itemset



Support: (4, 2)

Negative

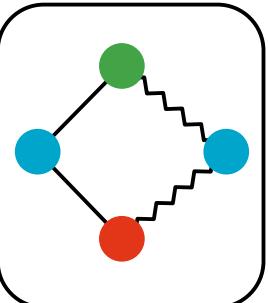
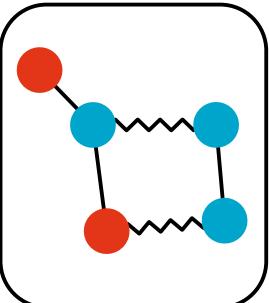
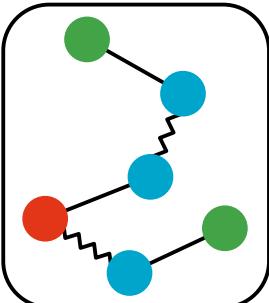
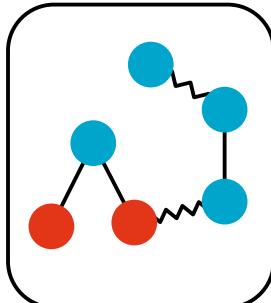


Support: (2, 1)

Supervised Subgraph Mining

- Find **discriminative patterns** from **supervised** data

Positive

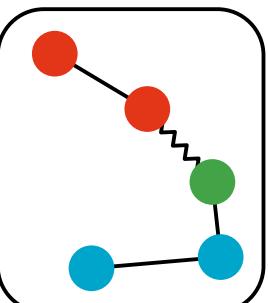
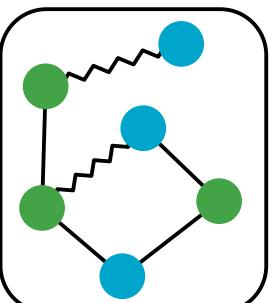
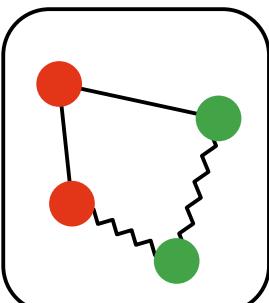
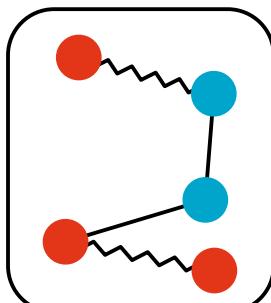


Discriminative
subgraphs



Support: (4, 0)

Negative



Support: (0, 2)

Contingency Table

	Occurrence	Non-occurrence	Total
Positive	$\text{supp}_C(x)$	$ C - \text{supp}_C(x)$	$ C $
Negative	$\text{supp}_{\bar{C}}(x)$	$ \bar{C} - \text{supp}_{\bar{C}}(x)$	$ \bar{C} $
Total	$\text{supp}(x)$ $= \text{supp}_C(x) + \text{supp}_{\bar{C}}(x)$	$ D - \text{supp}(x)$	$ D $

Contingency Table

	Occurrence	Non-occurrence	Total
Positive	n_{11}	n_{12}	c_1
Negative	n_{21}	n_{22}	c_2
Total	s	s'	d

Various Measures

- Confidence: n_{11}/d

- Growth rate (relative risk): n_{11}/n_{21}

- Support difference (risk difference): $n_{11} - n_{21}$

- Mutual information:

$$\frac{n_{11}}{d} \log \frac{n_{11}/d}{c_1 s/d^2} + \frac{n_{12}}{d} \log \frac{n_{12}/d}{c_1 s'/d^2} + \frac{n_{21}}{d} \log \frac{n_{21}/d}{c_2 s/d^2} + \frac{n_{22}}{d} \log \frac{n_{22}/d}{c_2 s'/d^2}$$

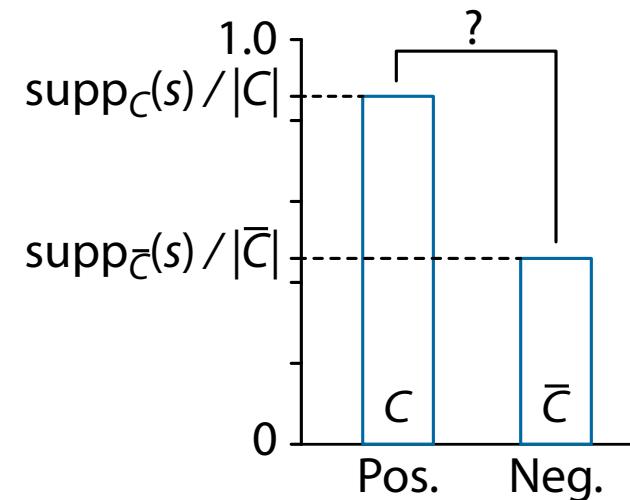
- Subgroup discovery measure (weighted relative accuracy):

$$(c_1/d)((n_{11}/c_1) - (c_1/d))$$

Computing p -value of Pattern

- Given positive and negative sample sets C, \bar{C} such that $D = C \cup \bar{C}$
- The p -value of each pattern s is assessed by the Fisher's exact test

	Occ.	Non-occ.	Total
C (Pos.)	$\text{supp}_C(s)$	$ C - \text{supp}_C(s)$	$ C $
\bar{C} (Neg.)	$\text{supp}_{\bar{C}}(s)$	$ \bar{C} - \text{supp}_{\bar{C}}(s)$	$ \bar{C} $
D (Total)	$\text{supp}(s)$	$ D - \text{supp}(s)$	$ D $

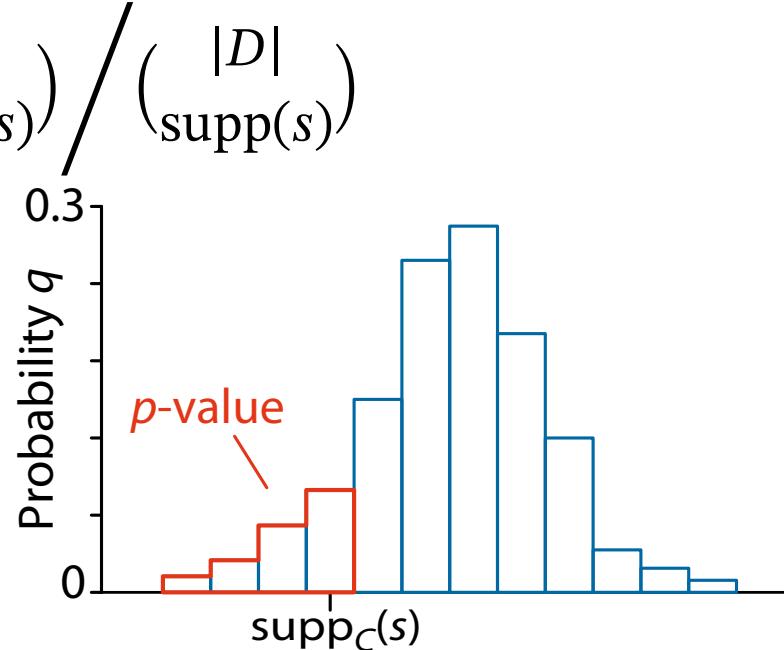


Fisher's Exact Test

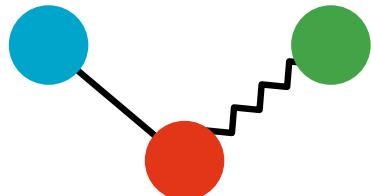
- Probability $q(\text{supp}_C(s))$ is given by hypergeometric distribution:

$$q(\text{supp}_C(s)) = \binom{|C|}{\text{supp}_C(s)} \binom{|\bar{C}|}{\text{supp}_{\bar{C}}(s)} \binom{|D|}{\text{supp}(s)}$$

	Occ.	Non-occ.	Total
C (Pos.)	$\text{supp}_C(s)$	$ C - \text{supp}_C(s)$	$ C $
\bar{C} (Neg.)	$\text{supp}_{\bar{C}}(s)$	$ \bar{C} - \text{supp}_{\bar{C}}(s)$	$ \bar{C} $
D (Total)	$\text{supp}(s)$	$ D - \text{supp}(s)$	$ D $



Hypothesis Test for Each Pattern



Alternative hypothesis
is true

Null hypothesis
is true

Declared significant
($p\text{-value} < \alpha$)

True Positive

False Positive
(Type I Error)

Declared
non-significant

False Negative
(Type II Error)

True Negative

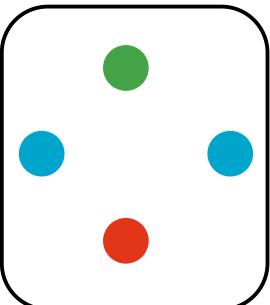
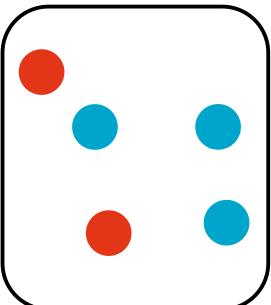
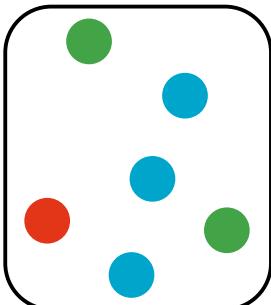
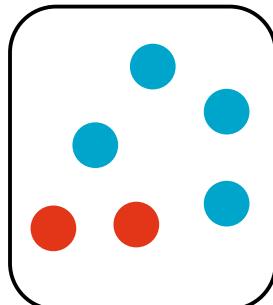
Null: Occurrence of pattern is **independent** from classes

Alternative: Occurrence of pattern is **associated with** classes

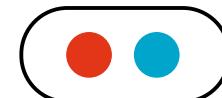
Significant Pattern (Itemset) Mining

- Find **discriminative patterns** from **supervised** data

Positive

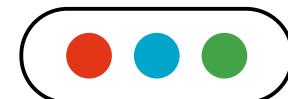
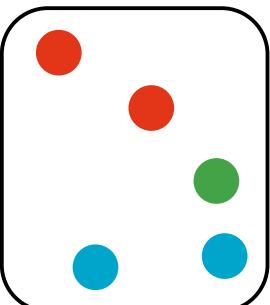
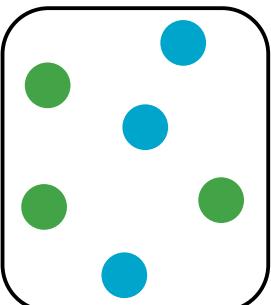
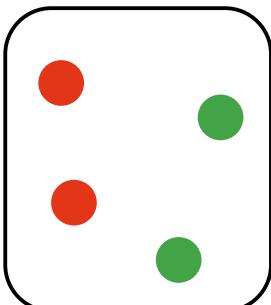
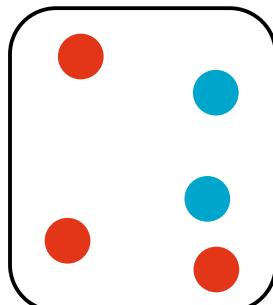


Significant itemset



Support: (4, 2)
 $p\text{-value} = 0.214$

Negative

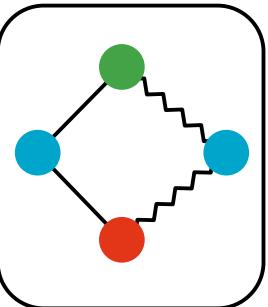
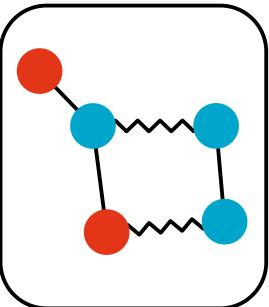
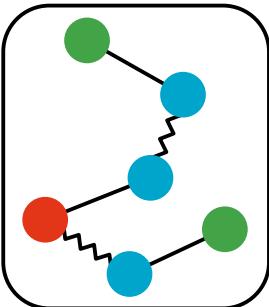
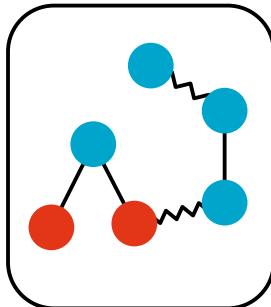


Support: (2, 1)
 $p\text{-value} = 0.5$

Significant Subgraph Mining

- Find **discriminative patterns** from **supervised** data

Positive

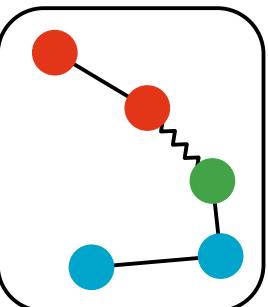
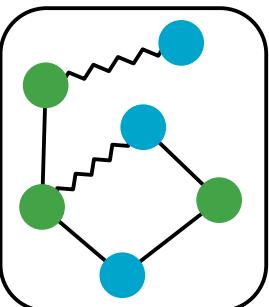
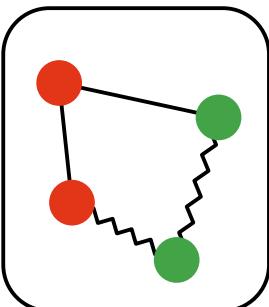
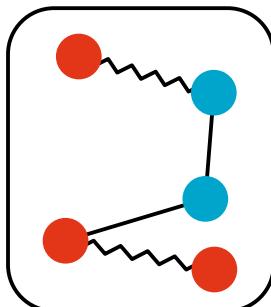


Significant
subgraphs



Support: (4, 0)
 $p\text{-value} = 0.0143$

Negative

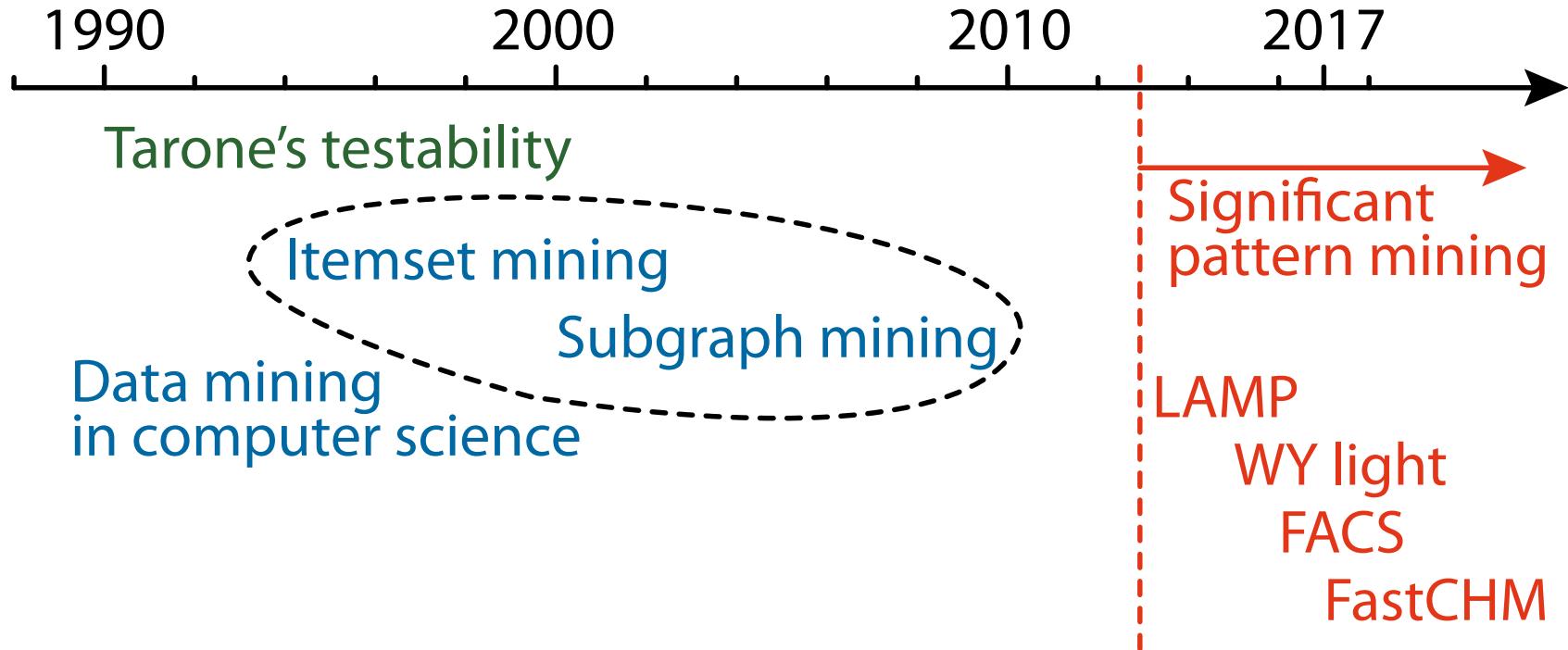


Support: (0, 2)
 $p\text{-value} = 0.214$

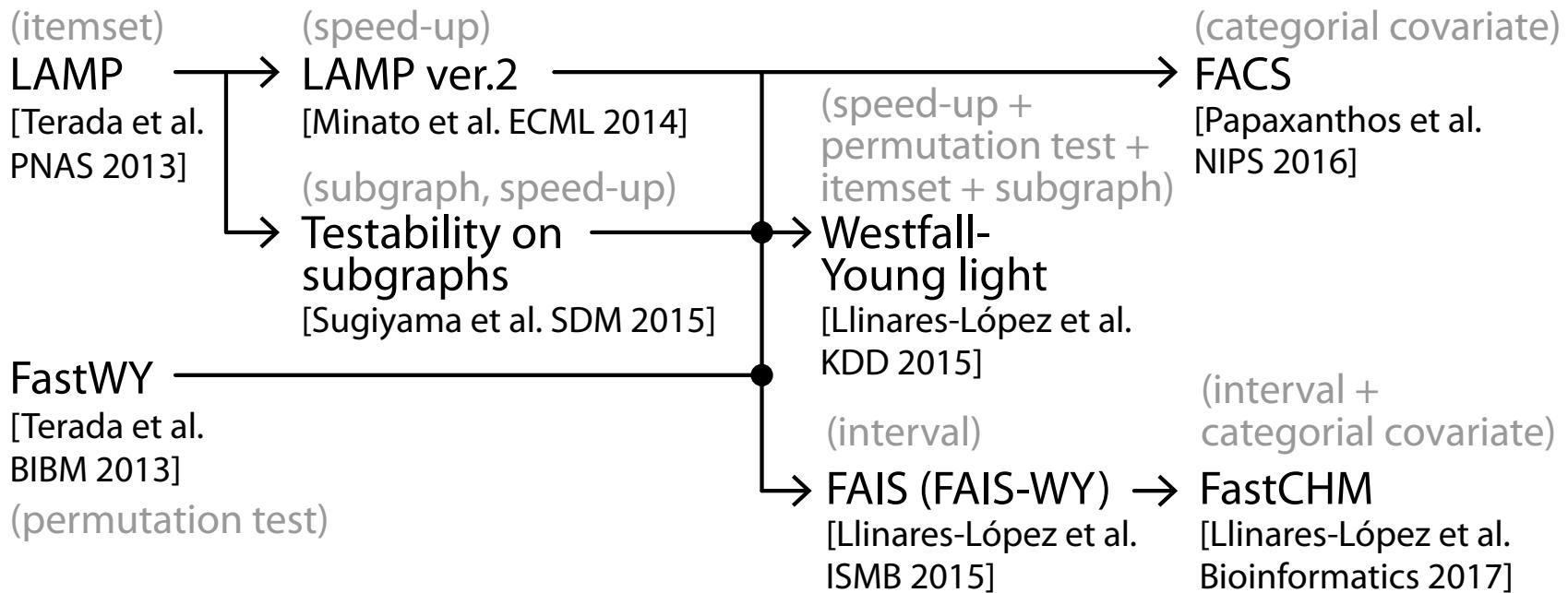
Challenges and Solutions of SPM

1. **(Computational)** How to check all patterns with avoiding **combinatorial explosion**?
 2. **(Statistical)** How to measure the statistical association (i.e. p -value) with correcting for multiple testing with avoiding **combinatorial explosion**?
- **Answer: Tarone's trick + Apriori principle**
 - The **Tarone's trick** to define patterns that are irrelevant
 - The **Apriori principle** to efficiently prune such patterns using the partial order structure of patterns

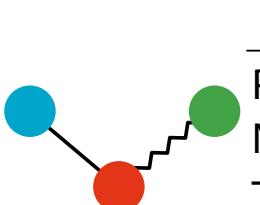
Timeline



Summary of SPM Methods



Multiple Testing



	Occ.	Non-occ.	Total
Positive	4	0	4
Negative	2	2	4
Total	6	2	8

Fisher's exact test: *p*-value = 0.429

Multiple Testing

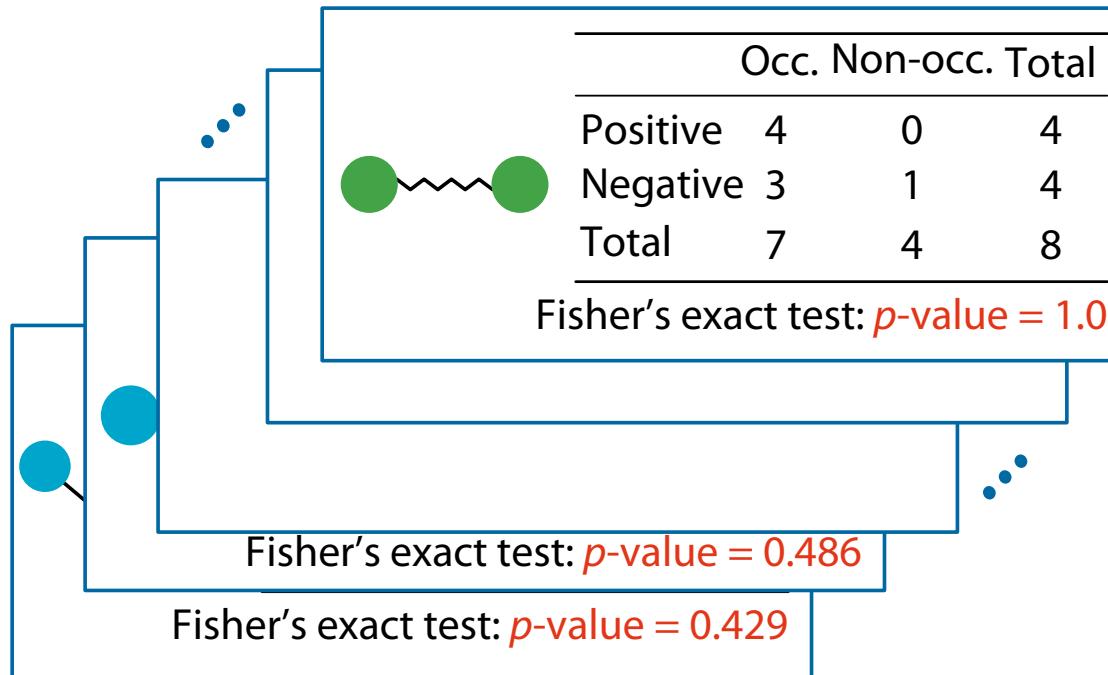


	Occ.	Non-occ.	Total
Positive	3	1	4
Negative	1	3	4
Total	4	4	8

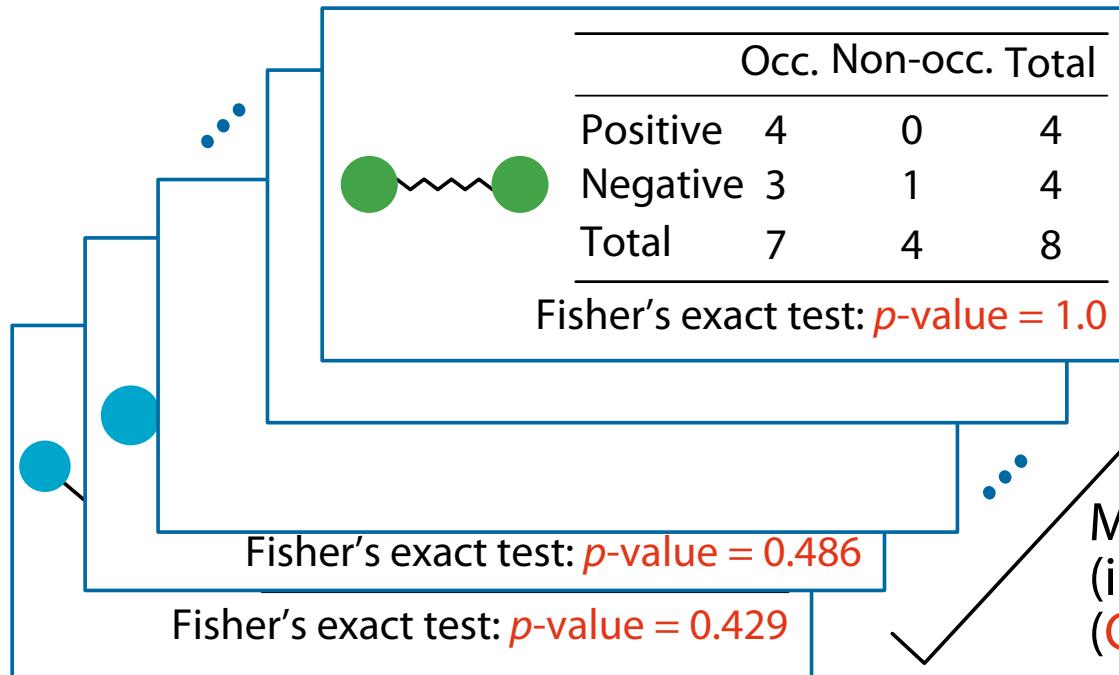
Fisher's exact test: $p\text{-value} = 0.486$

Fisher's exact test: $p\text{-value} = 0.429$

Multiple Testing



Multiple Testing



Task: Enumerate all significant patterns while controlling the FWER

Massive number of (infinitely many) patterns
(Combinatorial explosion!)

Multiple Testing Correction

- In each test, [probability of having a false positive] $\leq \alpha$
- If we repeat m tests, αm patterns can be false positives
 - Too many if m is large! For example in itemset mining:
 - For 100000 items, #patterns = 2^{100000}
 - Set significance level $\alpha = 0.01$
 - Number of false positives: $0.01 \cdot 2^{100000} = 10^{30101}$

Multiple Testing Correction

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 - For 100000 items, #patterns = 2^{100000}
 - Set significance level $\alpha = 0.01$
 - Number of false positives: $0.01 \cdot 2^{100000} = 10^{30101}$
- FWER (family-wise error rate): ***Probability of having more than one false positives among all patterns***
 - FWER = $1 - (1 - \alpha)^m$ if patterns are independent

Controlling the FWER

- $\text{FWER} = \Pr(\text{FP} > 0)$
 - FP: Number of false positives
- To achieve $\text{FWER} = \alpha$, change the significance level for each pattern from α to δ ($\delta \leq \alpha$), the **corrected significance level**

Controlling the FWER

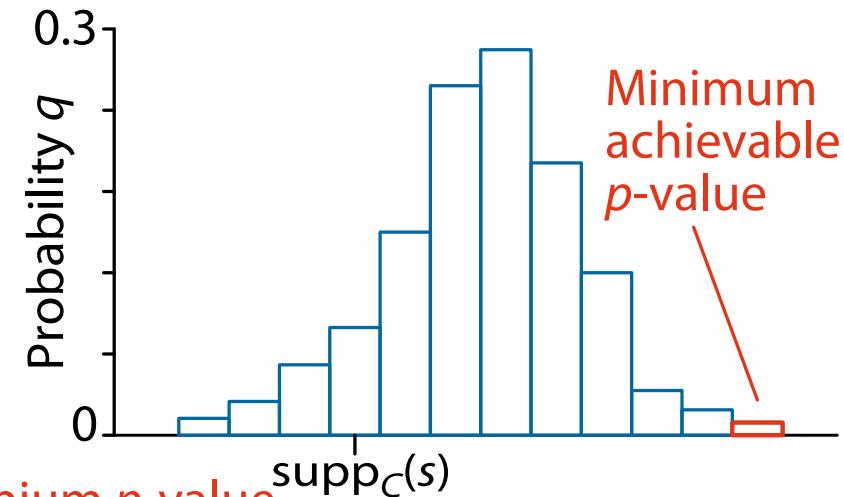
- $\text{FWER} = \Pr(\text{FP} > 0)$
 - FP: Number of false positives
- To achieve $\text{FWER} = \alpha$, change the significance level for each pattern from α to δ ($\delta \leq \alpha$), the **corrected significance level**
- **Objective:** Maximize $\text{FWER}(\delta)$ subject to $\text{FWER}(\delta) \leq \alpha$
 - $\text{FWER}(\delta)$: FWER at corrected significance level δ
 - Cannot be evaluated in closed form (simple but not easy!)
 - Bonferroni correction is popular: $\delta_{\text{Bon}}^* = \alpha/m$

Minimum Achievable p -value $\Psi(\sigma)$

- Consider the minimum achievable p -value $\Psi(s)$ of a pattern s for its support $\text{supp}(s)$

	Occ.	Non-occ.	Total
C (Pos.)	$\text{supp}(s)$	$ C - \text{supp}_C(s)$	$ C $
\bar{C} (Neg.)	0	$ \bar{C} - \text{supp}_{\bar{C}}(s)$	$ \bar{C} $
D (Total)	$\text{supp}(s)$	$ D - \text{supp}(s)$	$ D $

Most biased case that achieves the minium p -value

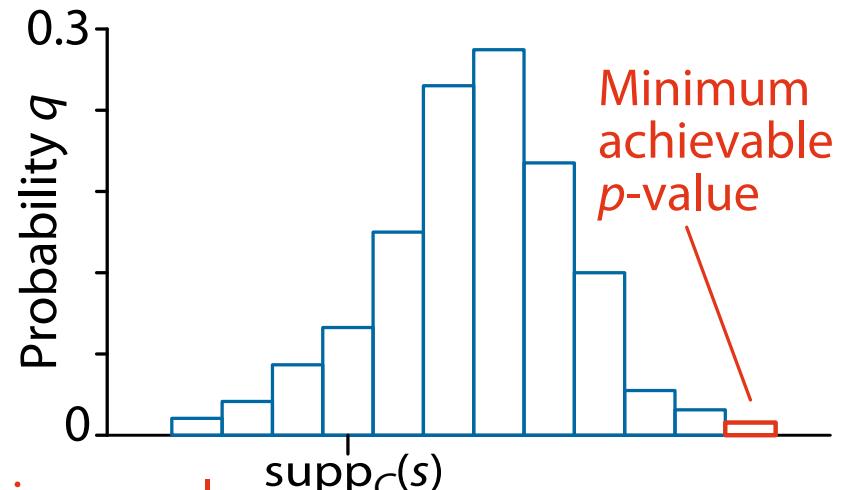


Computing $\Psi(s)$

$$\text{Minimum achievable } p\text{-value } \Psi(s) = \binom{|C|}{\text{supp}(s)} \Bigg/ \binom{|D|}{\text{supp}(s)}$$

	Occ.	Non-occ.	Total
C (Pos.)	$\text{supp}(s)$	$ C - \text{supp}_C(s)$	$ C $
\bar{C} (Neg.)	0	$ \bar{C} - \text{supp}_{\bar{C}}(s)$	$ \bar{C} $
D (Total)	$\text{supp}(s)$	$ D - \text{supp}(s)$	$ D $

Most biased case that achieves the minimum p -value



Tarone's Testability Trick

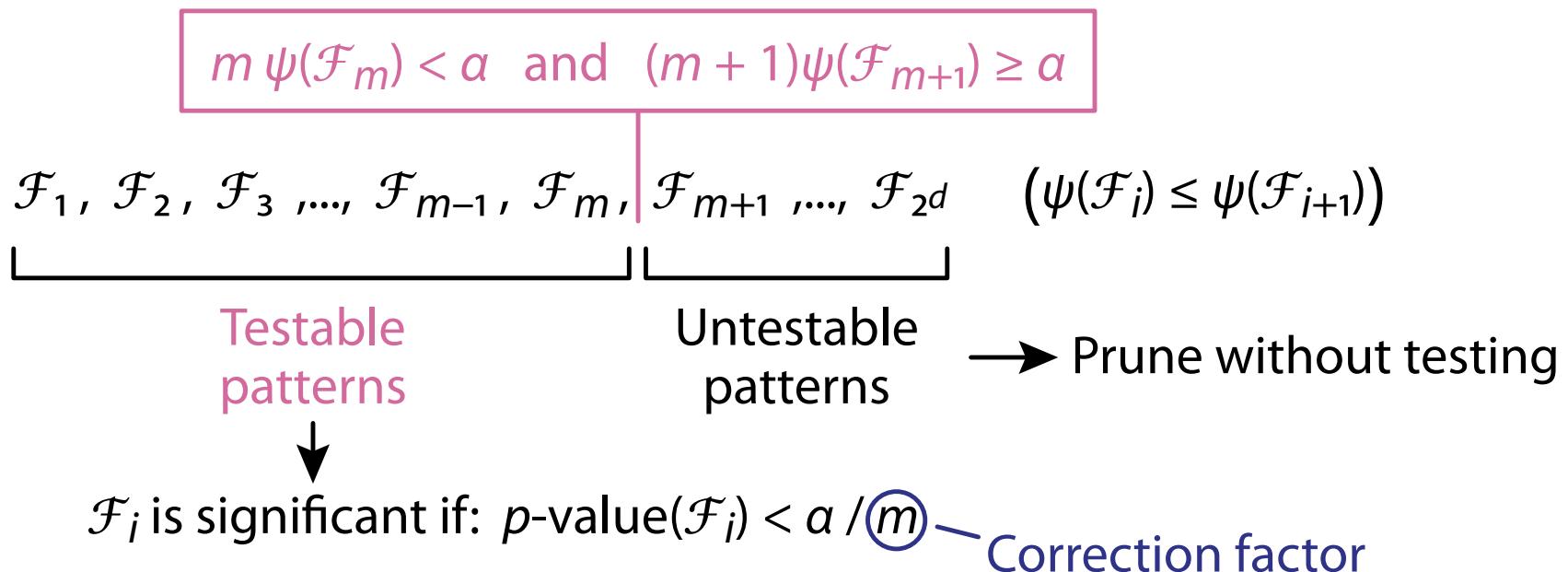
$$\mathcal{F}_1, \mathcal{F}_2, \mathcal{F}_3, \dots, \mathcal{F}_{m-1}, \mathcal{F}_m, \mathcal{F}_{m+1}, \dots, \mathcal{F}_{2^d} \quad (\psi(\mathcal{F}_i) \leq \psi(\mathcal{F}_{i+1}))$$

Tarone's Testability Trick

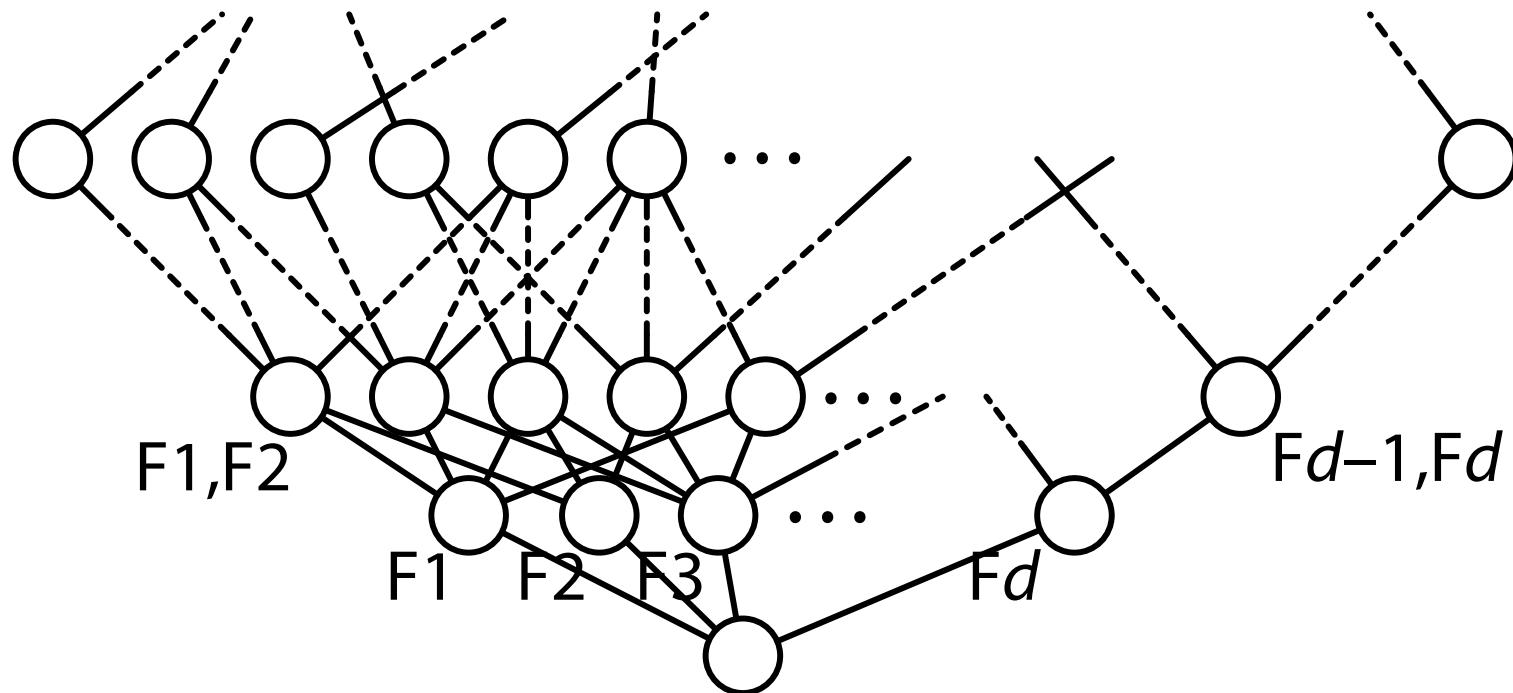
$$m \psi(\mathcal{F}_m) < \alpha \text{ and } (m+1)\psi(\mathcal{F}_{m+1}) \geq \alpha$$

$\mathcal{F}_1, \mathcal{F}_2, \mathcal{F}_3, \dots, \mathcal{F}_{m-1}, \mathcal{F}_m, \mathcal{F}_{m+1}, \dots, \mathcal{F}_{2^d} \quad (\psi(\mathcal{F}_i) \leq \psi(\mathcal{F}_{i+1}))$

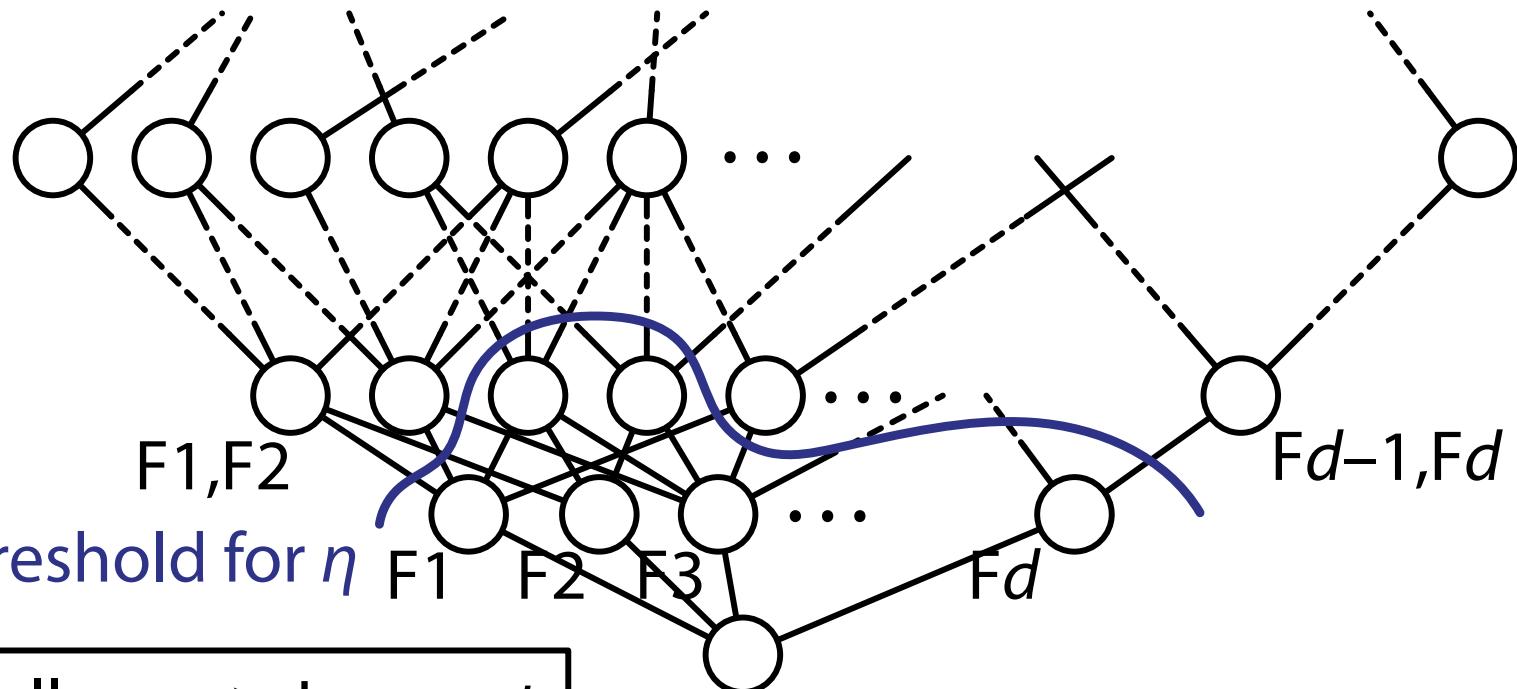
Tarone's Testability Trick



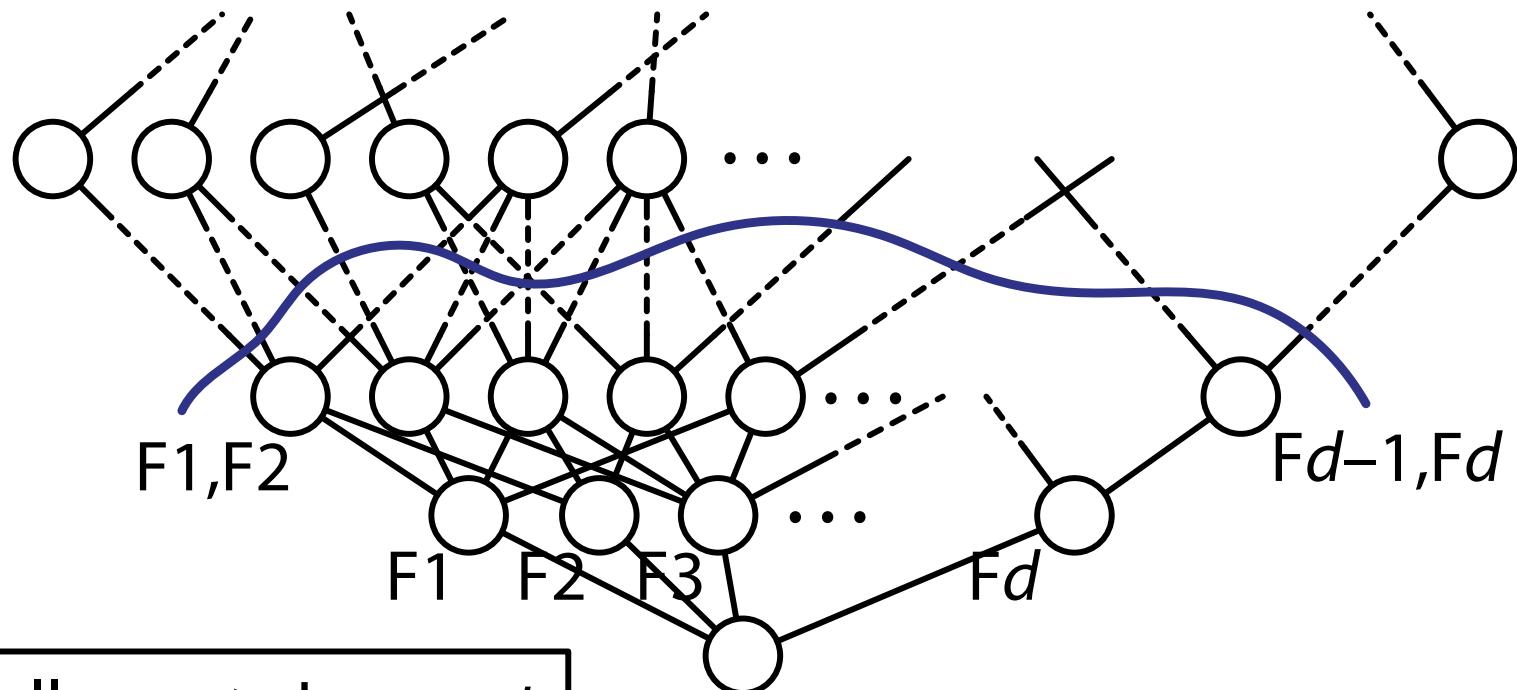
Enumeration Algorithm Based on Apriori



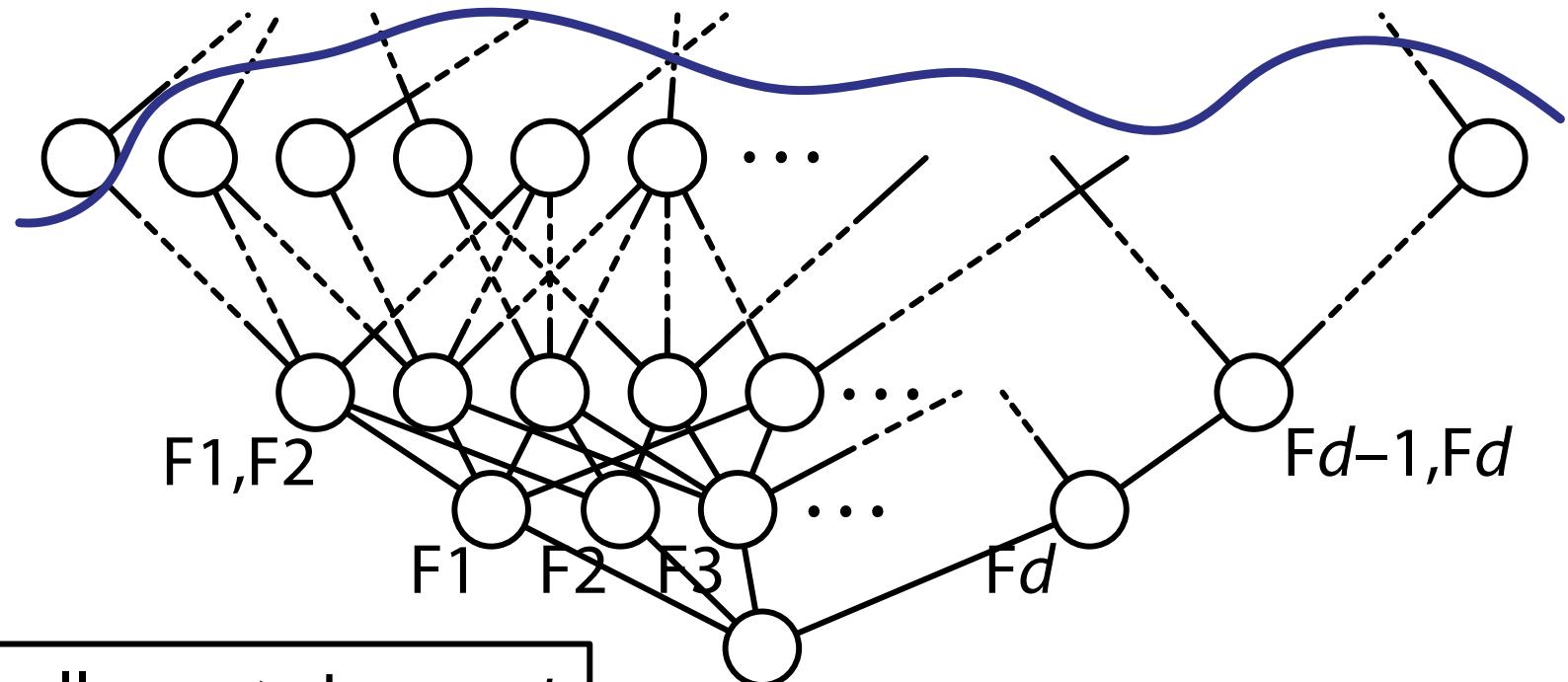
Enumeration Algorithm Based on Apriori



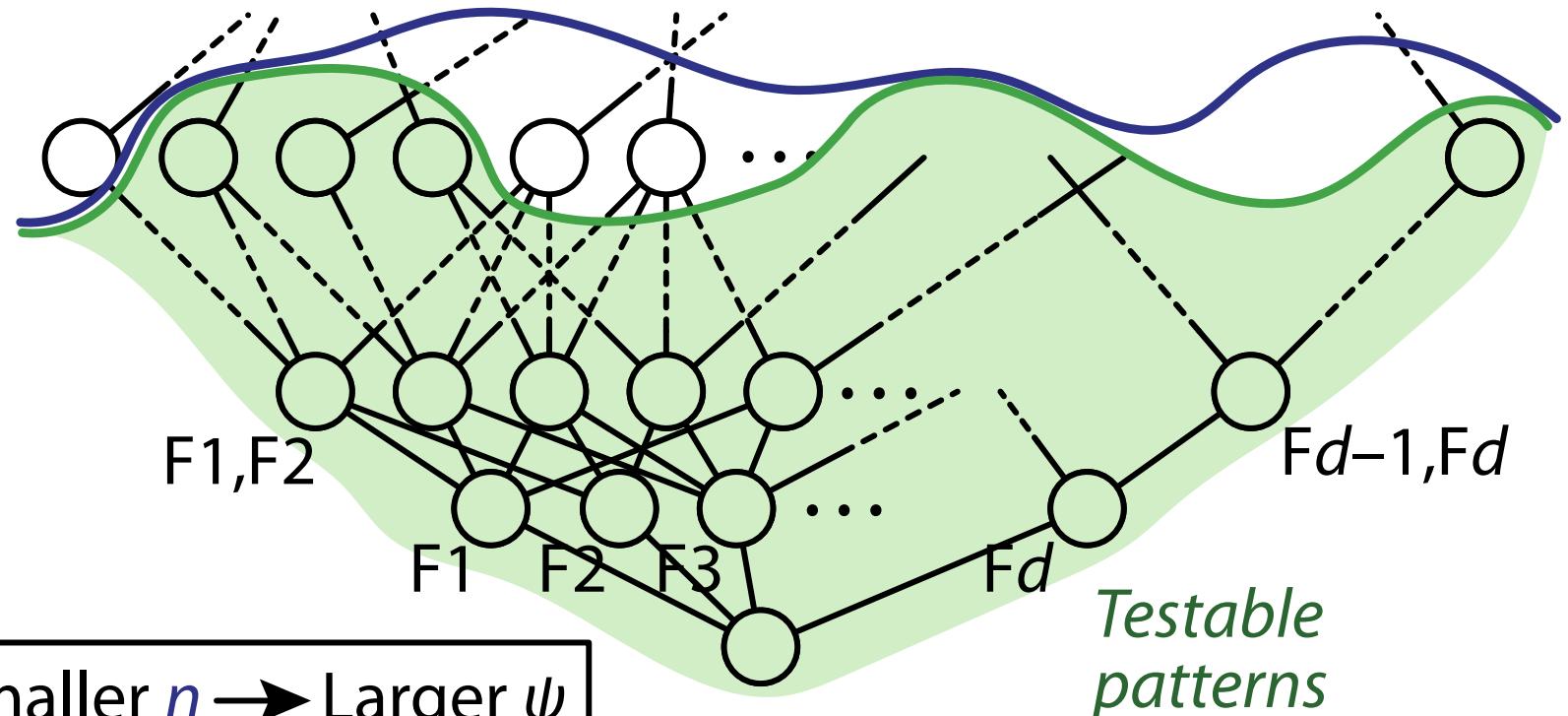
Enumeration Algorithm Based on Apriori



Enumeration Algorithm Based on Apriori

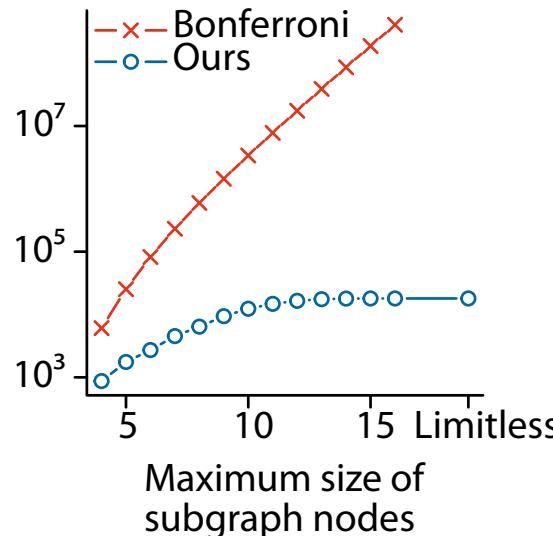


Enumeration Algorithm Based on Apriori

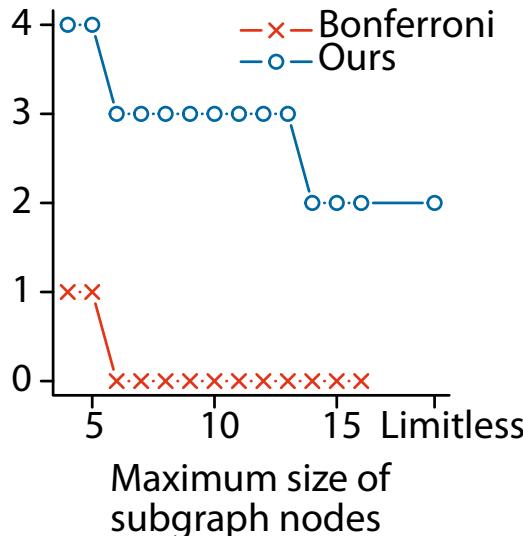


Power of Testability (Subgraph Mining)

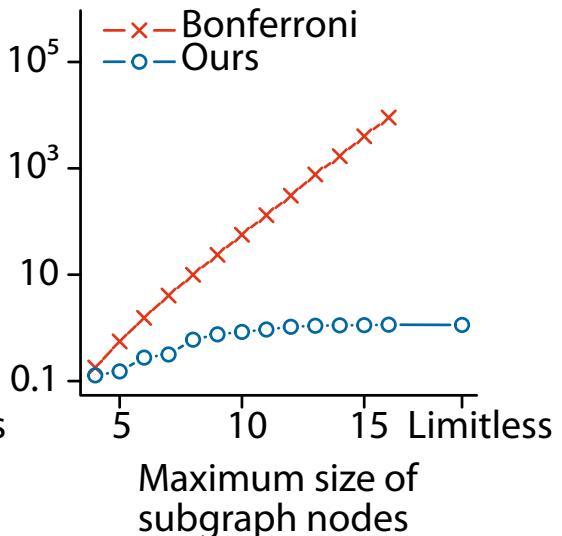
Correction factor



Number of significant subgraphs



Running time (second)



The PTC (Predictive Toxicology Challenge) dataset with 601 chemical compounds

Conclusion

- Supervised pattern mining has been considered
- Significant pattern mining is introduced
 - Find statistically significant patterns while controlling the FWER
 - pattern mining (data mining) + multiple testing correction (statistics)
 - Key technique: Tarone's trick